Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,854	CLAUS ET AL.	
Examiner	Art Unit	-
Hae M. Hyeon	2839	

	SEAR	CHED	 -
Class	Subclass	Date	Examiner
Search	Updated	2/06	hmh

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
439	194	2/06	hmh		
439	427	V	1		
	-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Interference Search Done	2/06	hmh	